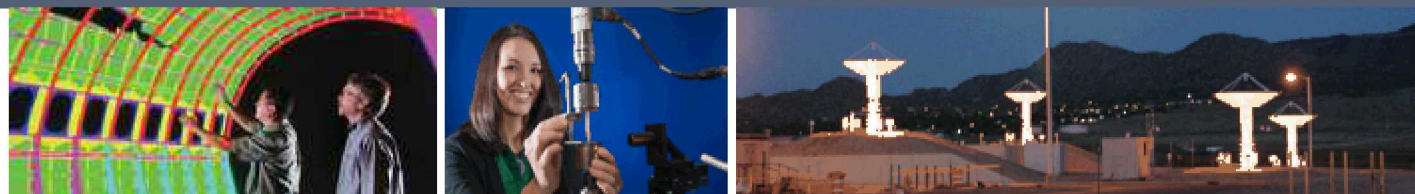
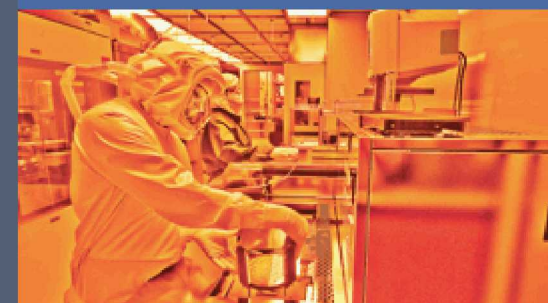


Reliability of Components that Contain Brittle Materials



PRESENTED BY

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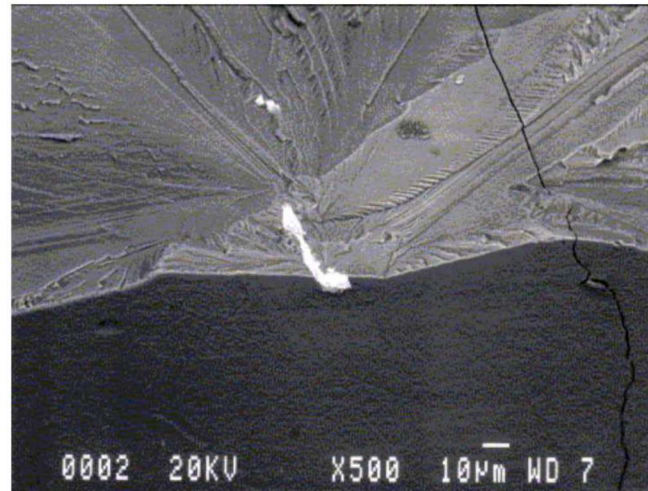
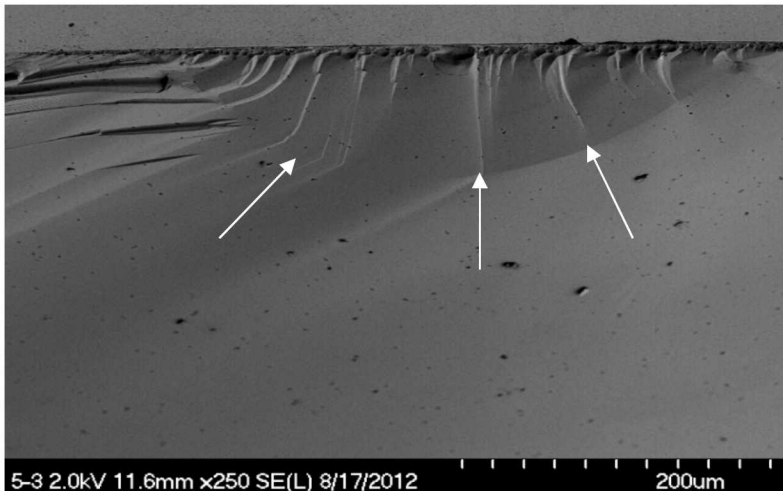
Outline

- Background
 - Failure Modes of Brittle Materials
 - Strength Size Scaling
 - Environmentally Enhanced Crack Growth
- Material Measurements
- FEA predictions
- Summary

Failure Modes

I. Fast (brittle) fracture due over load w/scale effect.

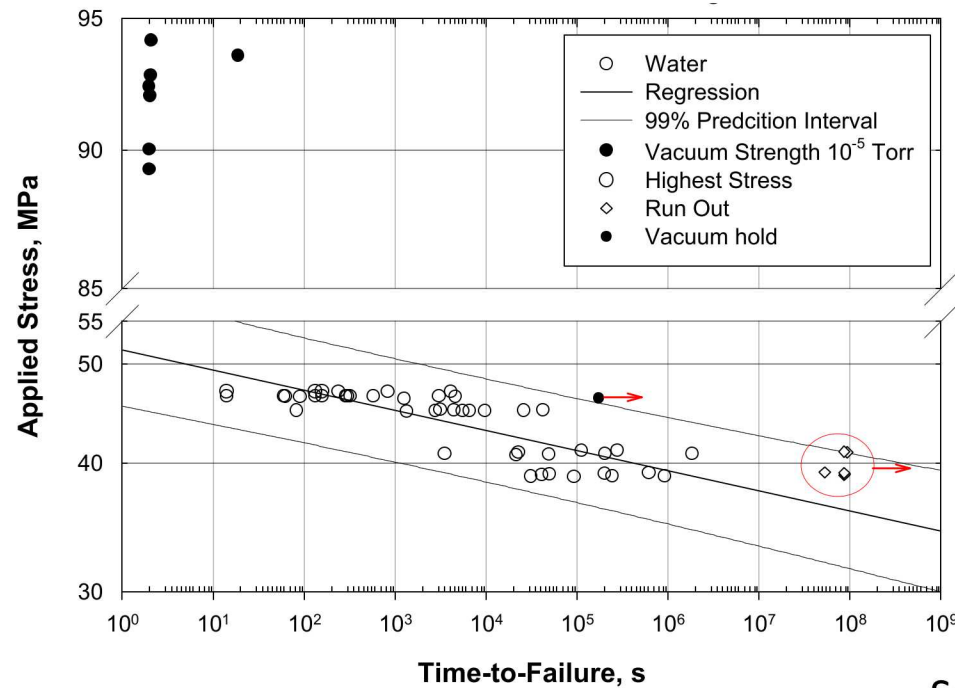
- For glasses and single X'tals, occurs from imperfections (scratches, checks, and infrequent pores and inclusion).
- Polycrystals: inclusions, coarse grains, agglomerates, pores and damage.



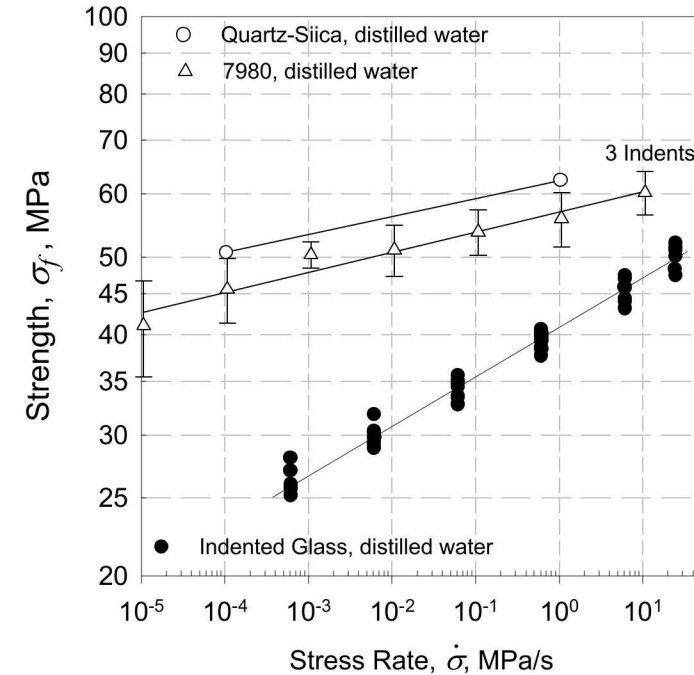
- Handling damage is surface distributed; pores are volume distributed.

Failure Modes

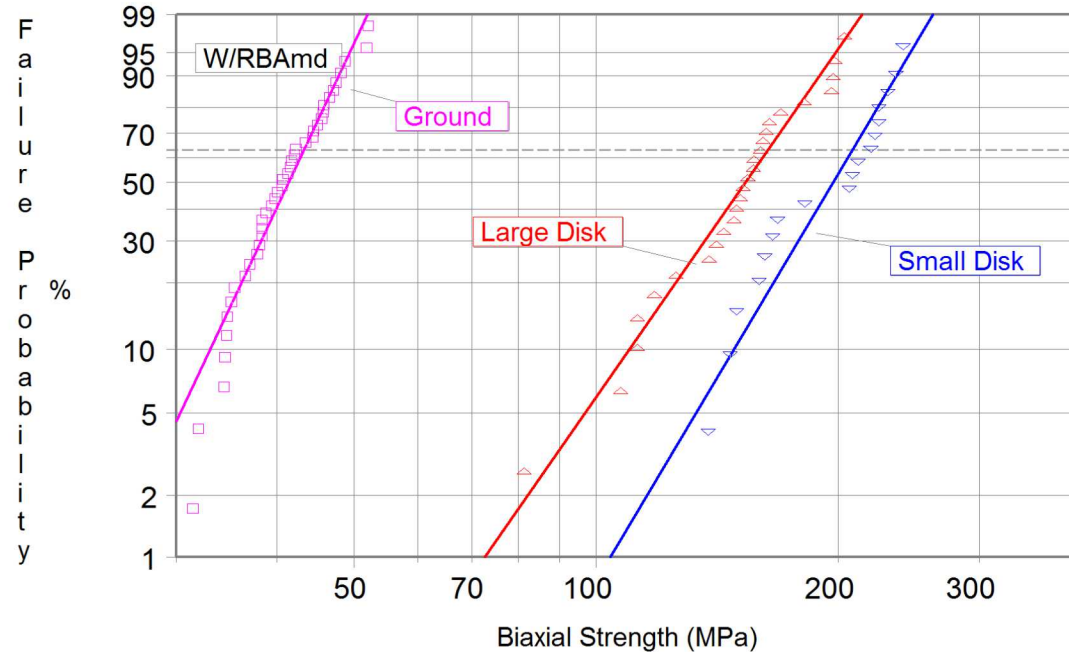
II. Slow crack growth (SCG) or “static fatigue.” Strength decreases with time under static load:



Salem-NASA



Size Effects and Multiple Flaw Populations



Weakest Link Behavior:

- Structure is analogous to a chain with many links of differing strength
- Catastrophic failure occurs when the weakest link is broken



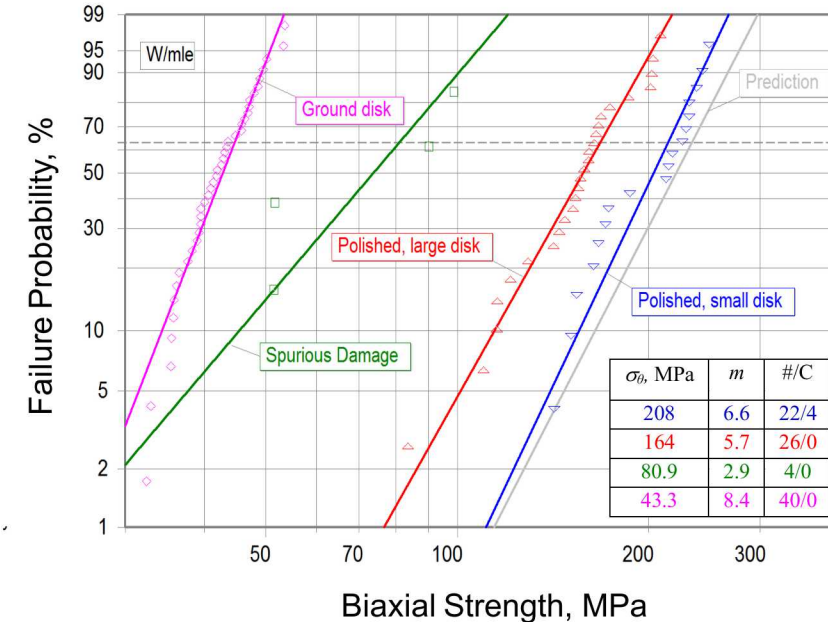
$$P_f = 1 - \exp[-(\sigma/\sigma_0)^\rho]$$

- Flaw population can change significantly, and strength is size dependent.
- Strength is *a variable*; not the inherent property. *Fracture toughness* is the inherent property: Strength results from the fracture toughness and flaw size present.
- Spurious damage lowers Weibull modulus and strength.
- Grinding distribution appear to be curved in 2-parameter Weibull space.....

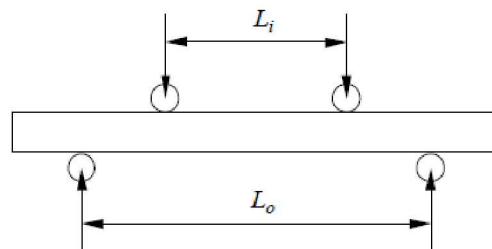
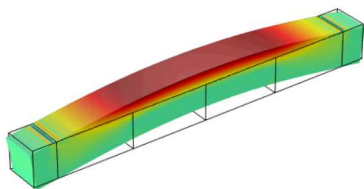
Accounting for Scale Effects - Effective Area

- General effective area solution:

$$A_{eff}^s = \int_{A^s} \left(\frac{\sigma}{\sigma_{max}} \right)^{m_A}$$

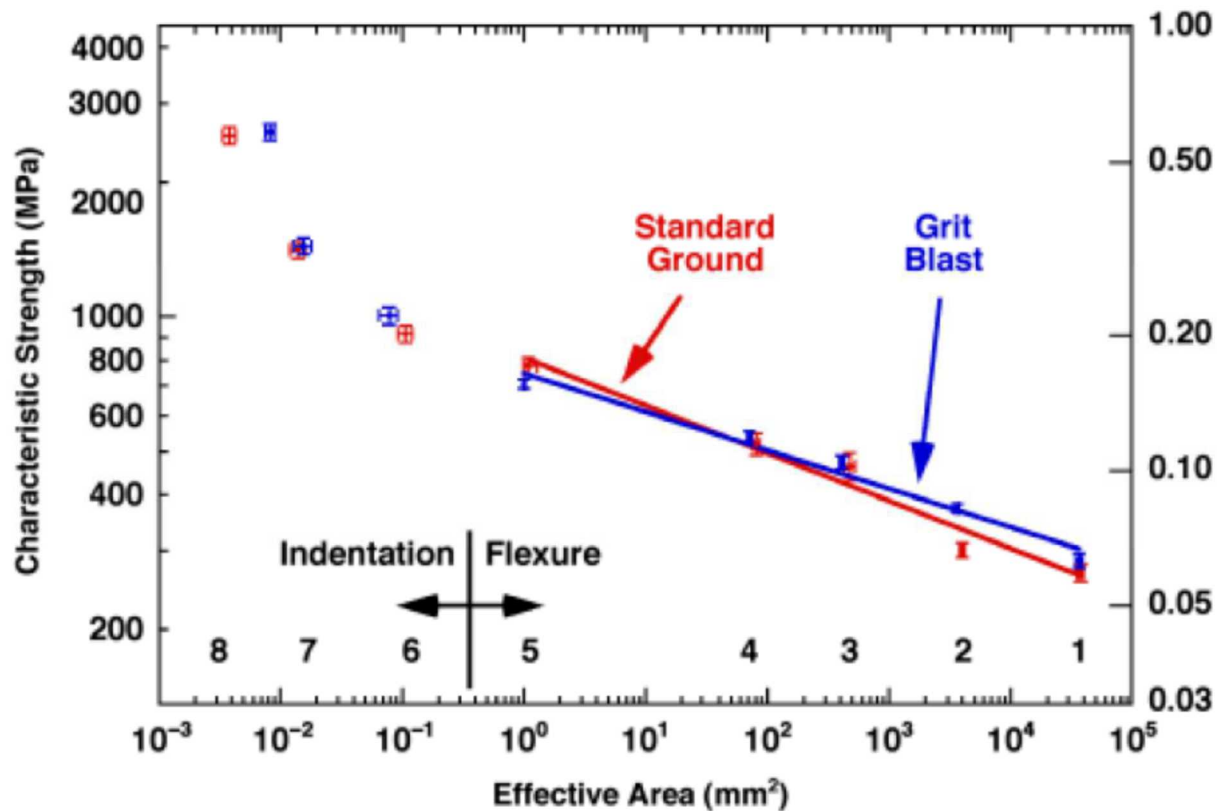


- Closed form solution for Effective Area of 4 Pt. Bend Bar:



$$A_{eff} = L_o \left[\left(\frac{d}{WM + 1} \right) + b \right] \left[\frac{\frac{L_i}{L_o} WM + 1}{WM + 1} \right]$$

Accounting for Scale Effects - Effective Area

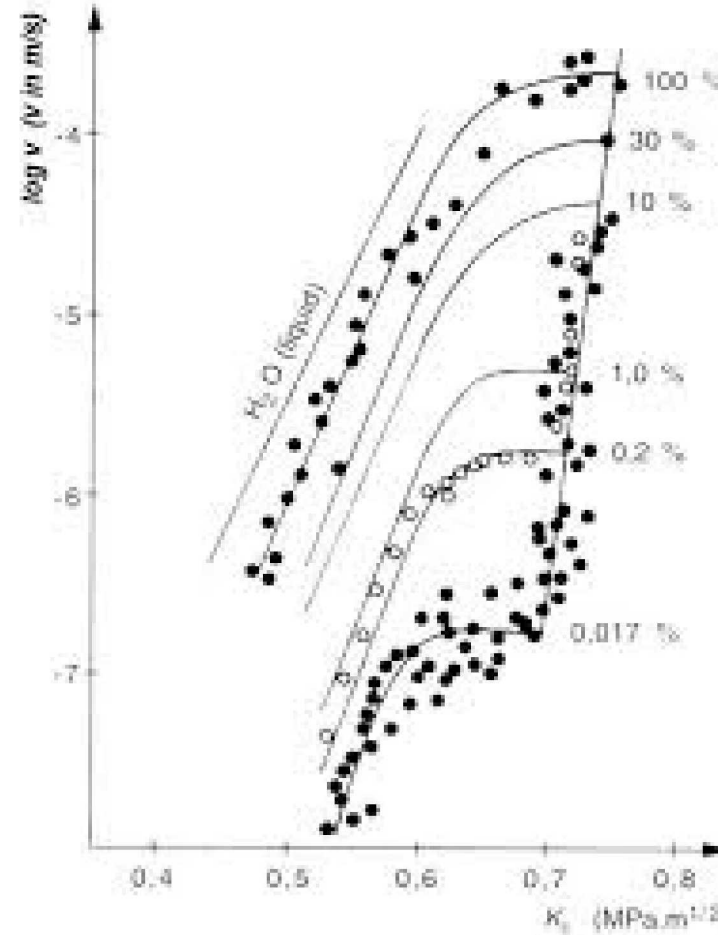
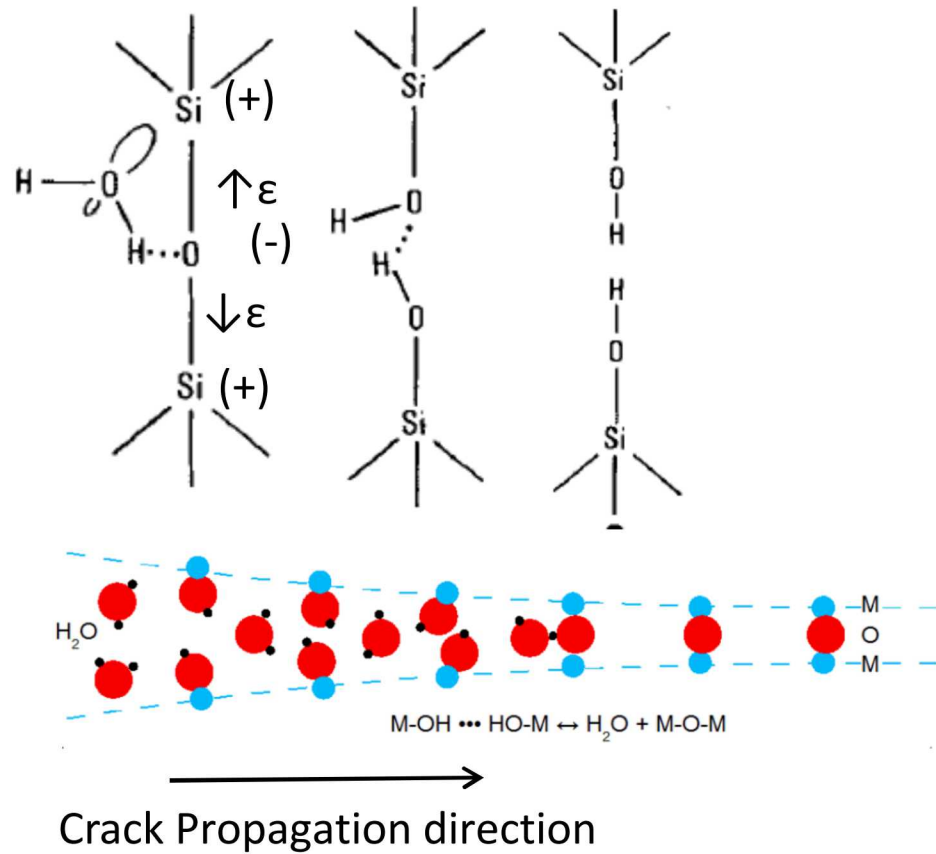


- 1 RoR: 140 / 280 mm rings
305 x 305 x 6.45 mm tiles
- 2 RoR: 45 / 90 mm rings
101.6 x 101.6 x 3.15 mm tiles
ARL-supplied data
- 3 RoR: 15 / 35 mm rings
50 x 50 x 2.64 mm tiles
- 4 RoR: 6.35 / 15.0 mm rings
25 x 25 x 1.18 mm tiles
- 5 BoR: 12.7 mm ball / 9 mm ring
25 x 25 x 1.18 mm tiles
- 6 Hertz: 47.62 mm Dia. Si3N4 Ball
- 7 Hertz: 12.70 mm Dia. Si3N4 Ball
- 8 Hertz: 3.00 mm Dia. Si3N4 Ball

$$S_B = \left(\frac{k_{AA} \times A_A}{k_{AB} \times A_B} \right)^{1/m} S_A$$

Mechanism - Environmentally Enhanced Crack Growth

Water causes intrinsic flaws (cracks) to slowly propagate at low stresses



Weiderhorn (1967)

$$v = A_1 \left(\frac{K_I}{K_{IC}} \right)^{n_1} \quad t_f = \frac{2}{Y^2 \sigma_a^2} \int_{K_{Ii}}^{K_{IC}} \frac{K_I}{v(K_I)} dK_I \quad 8$$

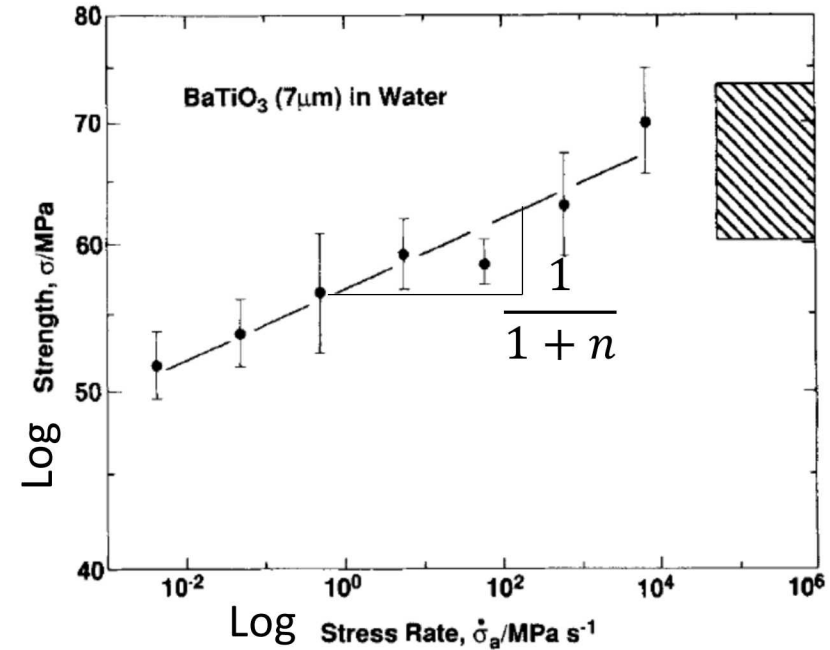
ASTM C1368

Determination of Slow Crack Growth Parameters

Test Setup



Test Results



$$\log \sigma_f = \frac{1}{1+n} \log \dot{\sigma} + \log D$$

Environmental material parameters can be determined from laboratory experiments.

Effect of atmosphere on aging of strength

- To predict the aging of the strength we assume that any flaws (small cracks) grow according to

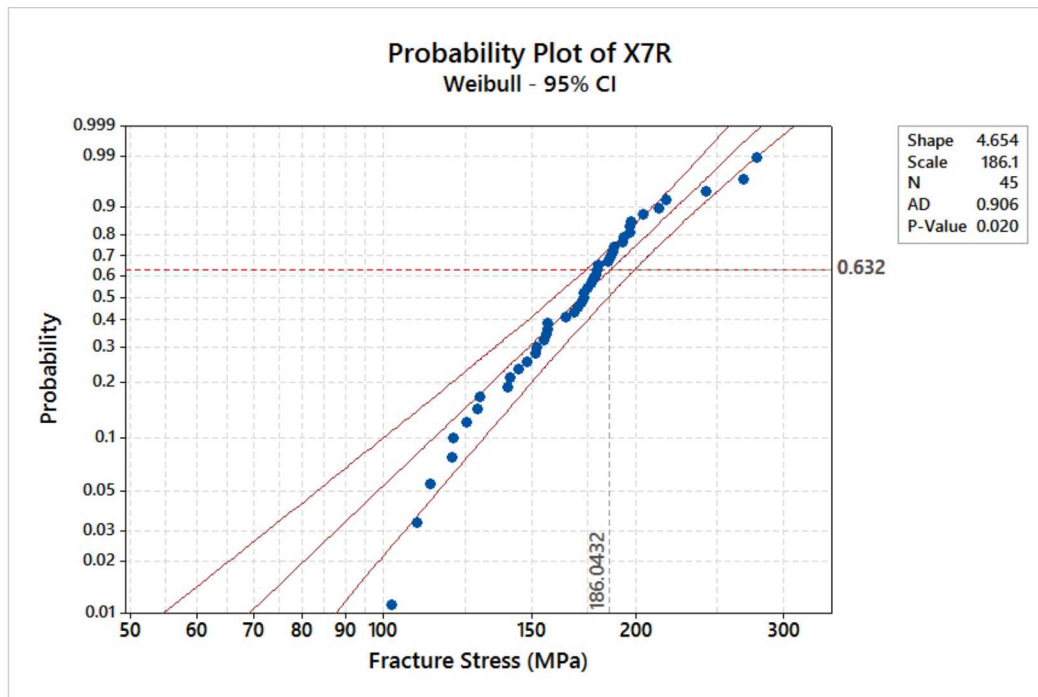
$$v = \dot{a} = A \cdot (K_I/K_{Ic})^n$$

- where a is crack length, K_I is mode I stress intensity factor from linear elastic fracture mechanics, K_{Ic} is fracture toughness, and A and n are fitting parameters
- At beginning of life, strength data is fit to the Weibull distribution, $P_{fail} = 1 - \exp \left[- \left(\frac{\sigma}{\sigma_0} \right)^\rho \right]$, which characterizes the flaws in the specimen
- Under a constant stress, σ_f , we assume the flaws grow according to the above velocity relation
- By integrating from an initial to a critical flaw size we predict that the aged strength distribution at some time t_f will be

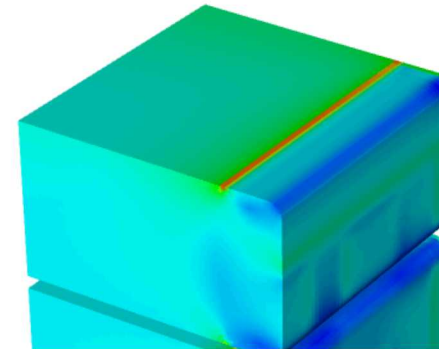
$$P_f = 1 - \exp \left(- \left\{ \frac{\left[\frac{A(n-2)Y^2\sigma_f^2 t_f}{2K_{Ic}^2} + 1 \right]^{\frac{1}{n-2}} \sigma_f}{\sigma_0} \right\}^\rho \right)$$

Stress predicted by model

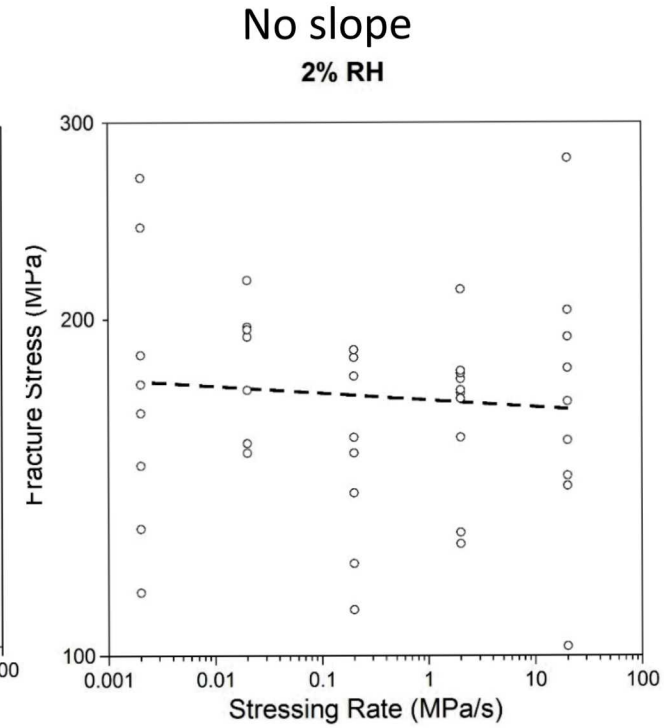
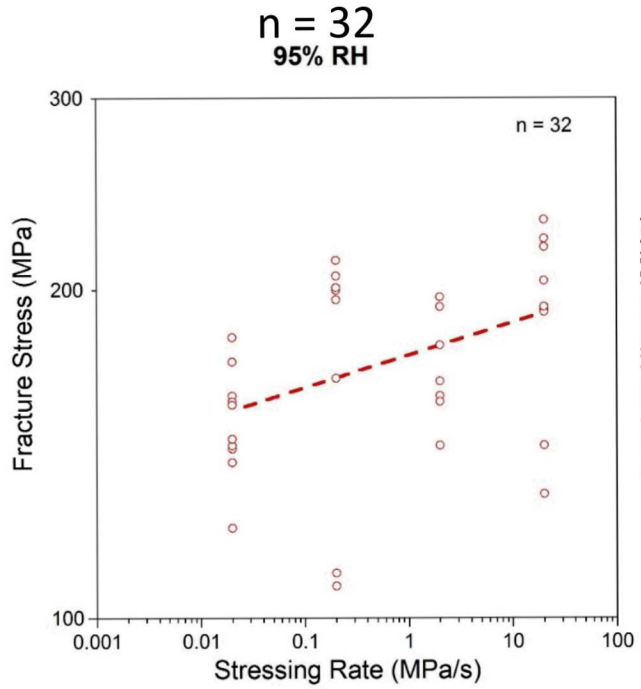
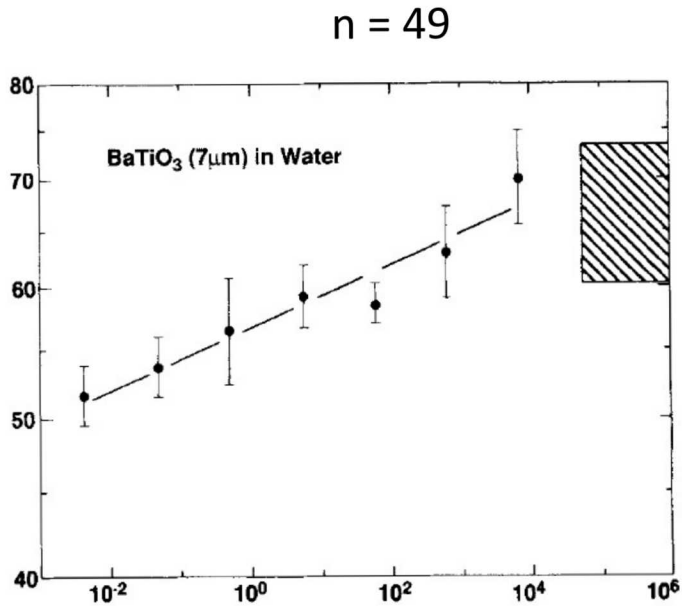
- Max stress predicted in model is approximately 105 Mpa
- Weibull strength ASTM-B 4 point bend bars is 186 MPa
- Weibull strength is that which corresponds to 63.2% probability of failure (consider this a measure of the average strength of the specimen)
- We can use these Weibull parameters to predict probability of failure from an arbitrary geometry and stress state
- Max stress and Weibull strength are of the same order of magnitude → We expect a non-negligible but relatively small probability of failure
 - 0.14% Probability of Failure



FEA Stress Analysis



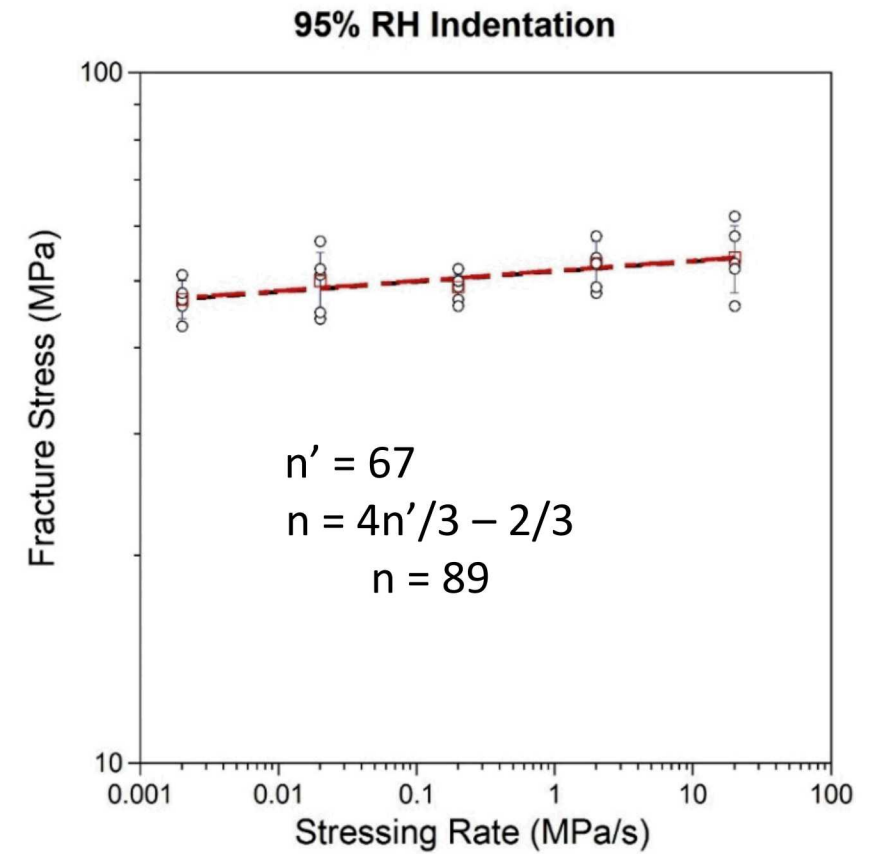
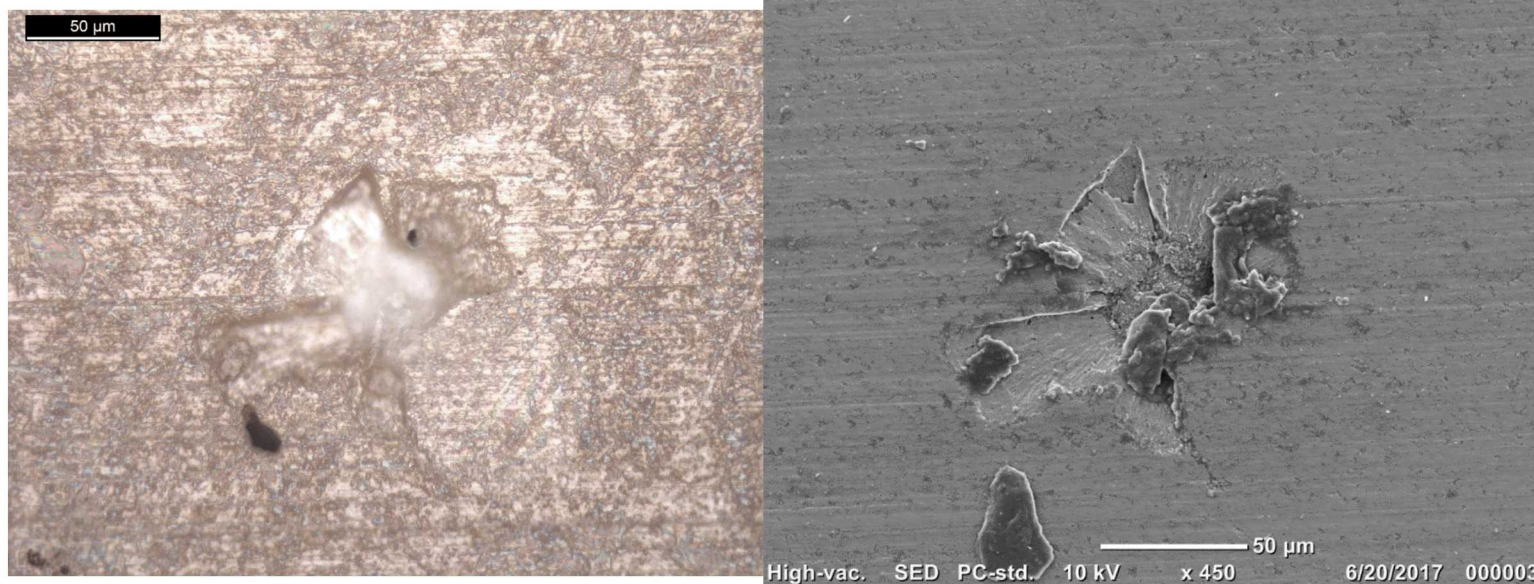
SCG Test Done



Higher the n value, the less susceptible a material is to sub-critical crack growth.

Indentation Strength

1 kgf \sim 60 μ m crack length

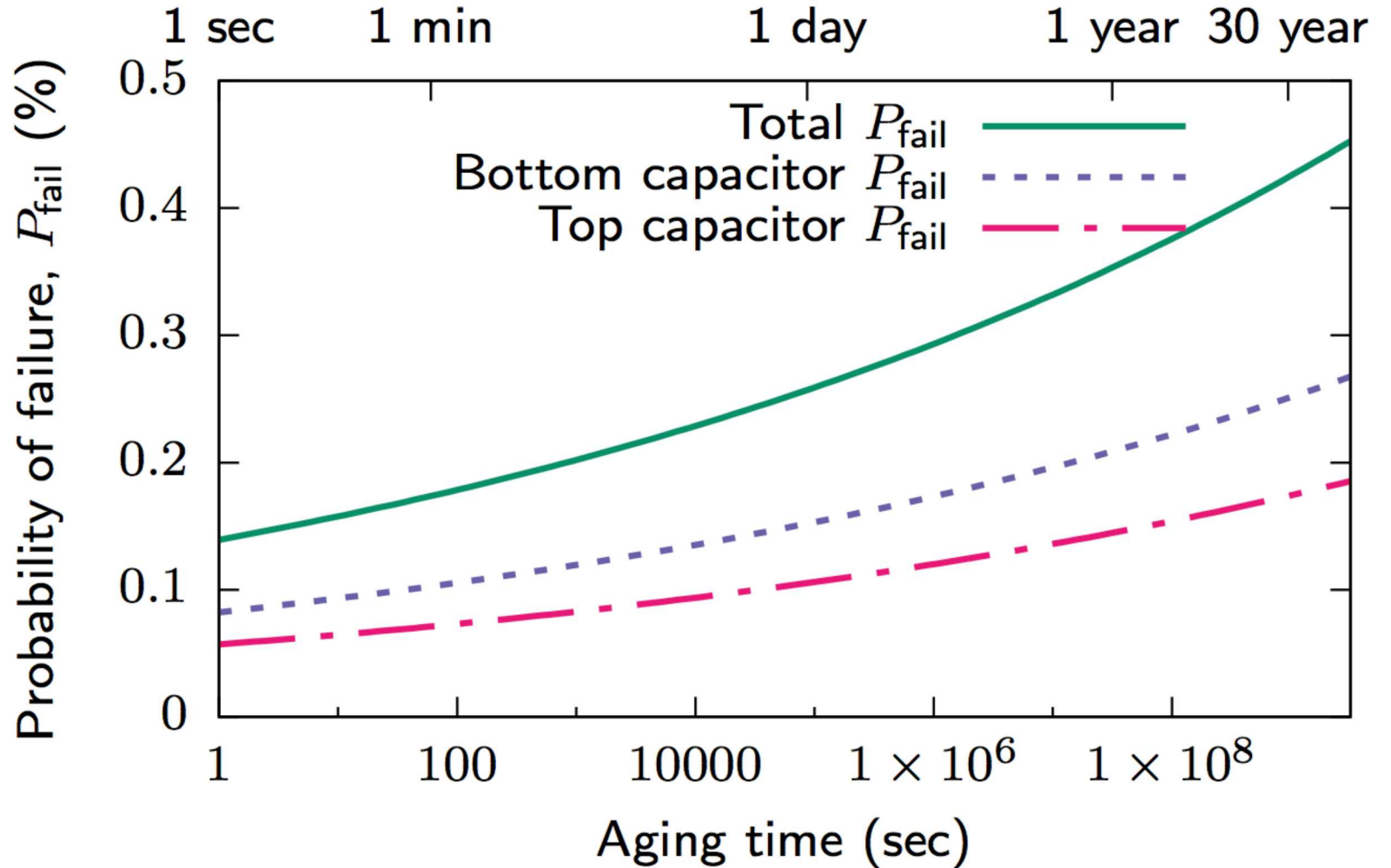


Evolution of failure probability

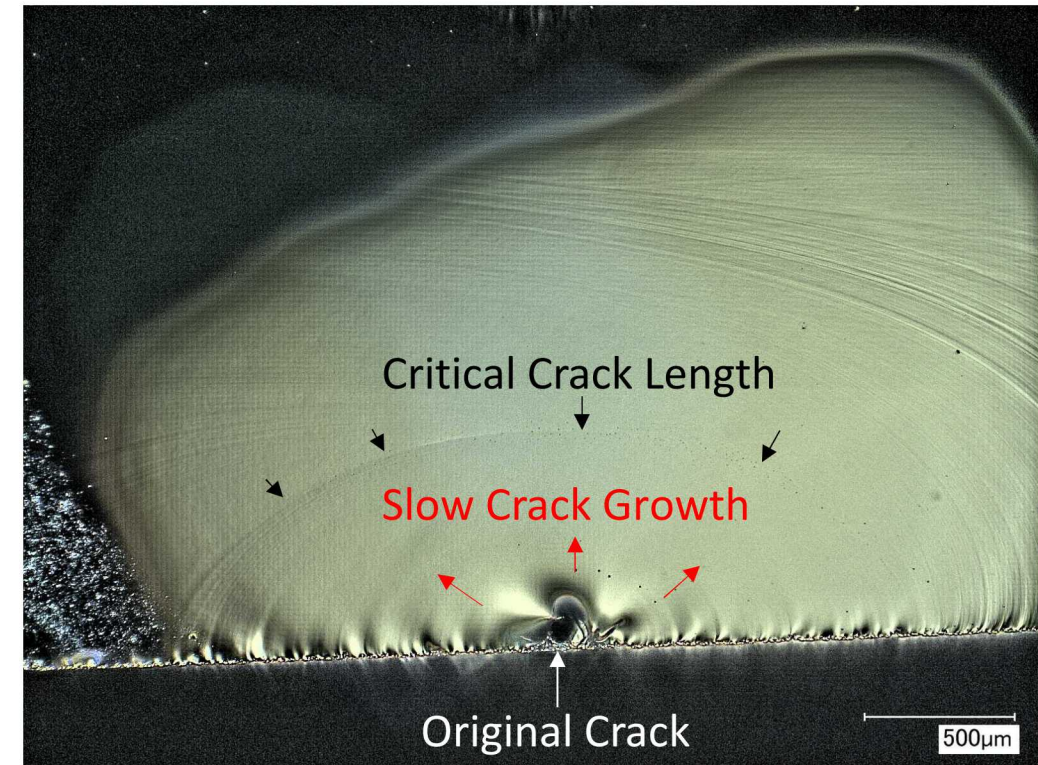
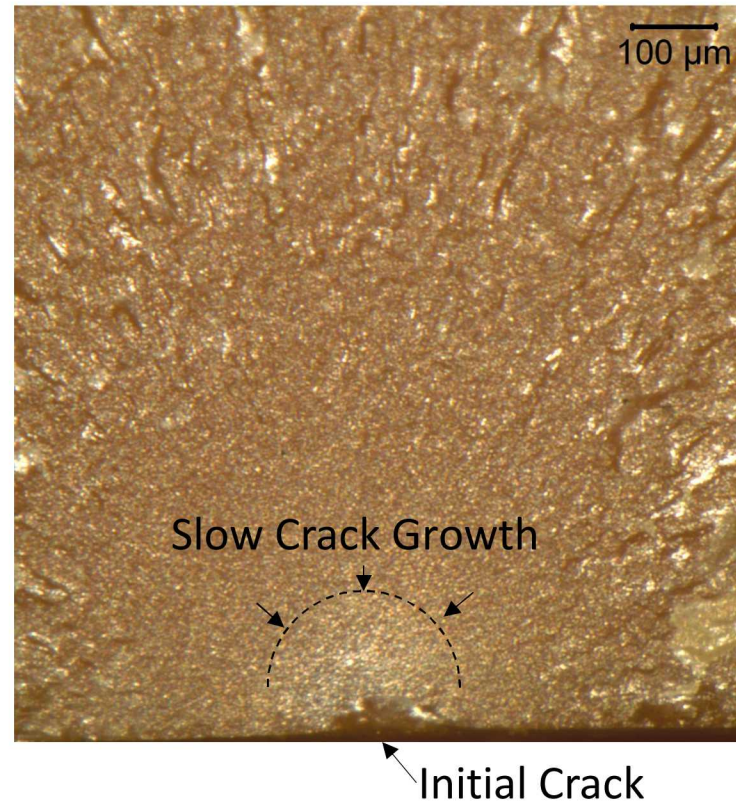
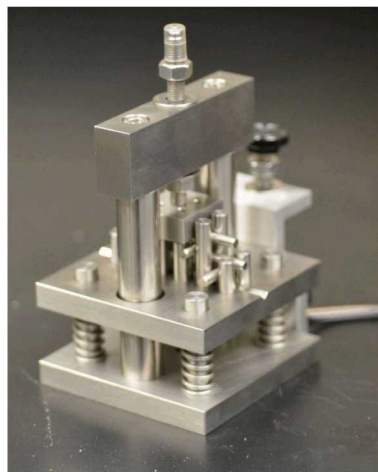
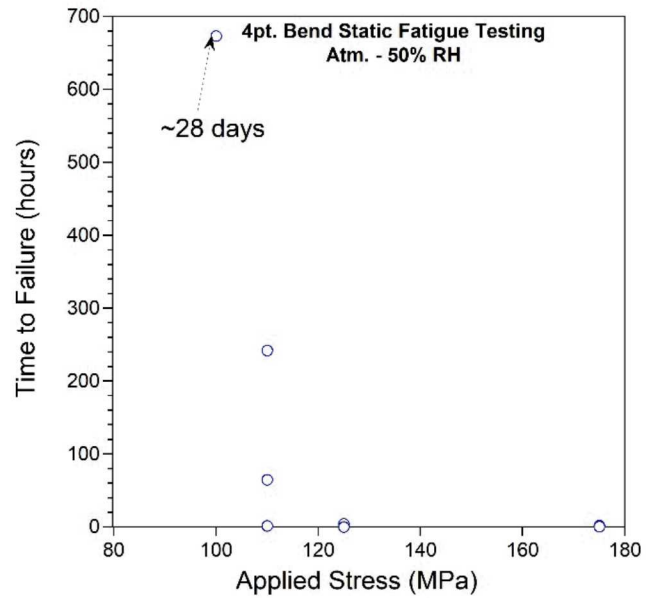
The relevant parameters in this case are:

- $\sigma_0=186$ MPa
- $\rho=4.654$
- $A=1.83 \cdot 10^{-3}$ m/s
- $n=90.7$
- $K_{IC}=1.06$ MPa m^{1/2}
- Geometry factor Y corresponding to a half penny surface flaw

For both capacitors considered together, we predict an increase in probability of failure from 0.14% to 0.42% over 30 years



Delayed Failure Results to Validate Models



Summary

- Predictive models exist and can be implemented
 - Based on empirical fits -> Need physics based model that can be implemented
- Basic assumptions
 - stress state is well known
 - flaw populations are well know
 - flaw populations don't change except via SCG
 - similitude
 - reasonable extrapolations (scale effect breakdown).